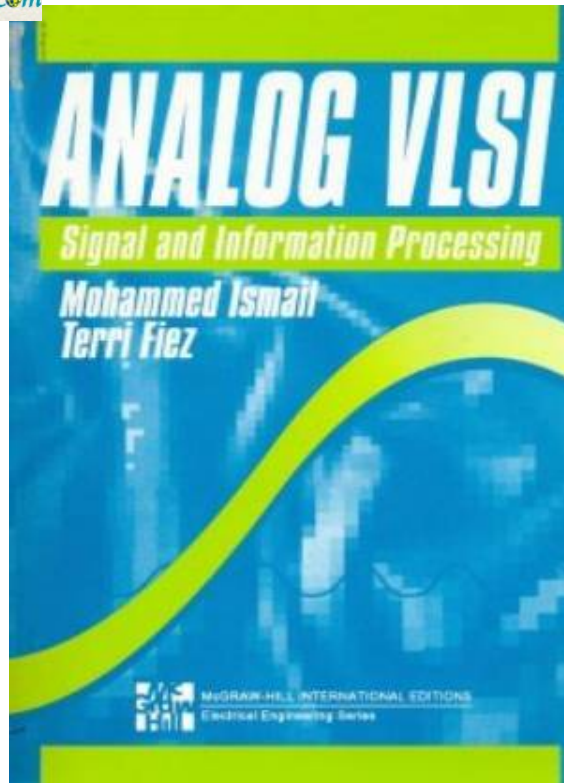




ANALOG VLSI SIGNAL AND INFORMATION PROCESSING

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TOP		

Each chapter provides basic This book presents the first comprehensive treatment of analog VLSI design for signal and information processing applications by blending the basic design concepts of both traditional and contemporary analog VLSI. Outstanding features of the text include coverage of the latest in analog VLSI putting students and practicing engineers on the cutting edge of this exciting field; thorough coverage of topics unique to this book including low-voltage, BiCMOS, current-mode and neural information processing, oversampled data converters, statistical design, analog testability, analog CAD, analog layout, and analog VLSI interconnects; avoids lengthy coverage of. Abstract. Analog VLSI signal processing is most effective when precision is not required, and is therefore an ideal solution for the implementation of perception systems. The possibility to choose the physical variable that represents each signal allows all the features of the transistor to be exploited opportunistically to implement very dense time- and amplitude-continuous processing cells. This paper describes a simple model that captures all the essential features of the transistor.